

**Search Notes**

Application/Control No.

10/530,876

Examiner

Karen Cheng

Applicant(s)/Patent under  
Reexamination

DORSCH ET AL.

Art Unit

1626

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN Structure Search (updated - see attached)	4/6/2007	KC